

Notice of References Cited	Application/Control No. 10/594,425		Applicant(s)/Patent Under Reexamination YANAGISHITA ET AL.	
	Examiner Crystal Murdoch		Art Unit 2628	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,855,939 A	08-1989	Fitzgerald et al.	345/419
*	B	US-5,297,241 A	03-1994	Hirr et al.	345/427
*	C	US-5,422,987 A	06-1995	Yamada, Yoichi	345/427
*	D	US-5,492,472 A	02-1996	Suarez, Sonda W.	434/92
*	E	US-5,692,115 A	11-1997	Itoh et al.	345/427
*	F	US-5,771,044 A	06-1998	Cragun et al.	345/420
*	G	US-5,821,941 A	10-1998	Millstein, Jerry	345/420
*	H	US-5,877,768 A	03-1999	Jain, Rajiv	345/421
*	I	US-2001/0043236 A1	11-2001	Yamamoto, Takashi	345/781
*	J	US-2003/0210244 A1	11-2003	Sasago et al.	345/419
*	K	US-2004/0136590 A1	07-2004	Brouwer, Albert-Jan	382/154
*	L	US-6,912,293 B1	06-2005	Korobkin, Carl P.	382/100
*	M	US-6,906,712 B2	06-2005	Lee et al.	345/420

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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